

Dual P-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	-100			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -10 \text{ V}$	0.110			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -4.5 \text{ V}$	0.155			
Q _g typ. (nC)	5.65			
I _D (A)	-4.5			
Configuration	Single			

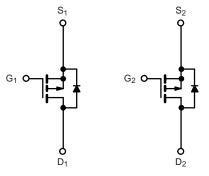
FEATURES

- TrenchFET® power MOSFET
- 100 % R_g and UIS tested



APPLICATIONS

- Active clamp in intermediate DC/DC power supplies
- LED Lighting
- Load switch



P-Channel MOSFET

P-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V_{DS}	-100	V	
Gate-source voltage		V _{GS}	± 20	V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-4.5		
	$T_C = 70 ^{\circ}C$ $T_A = 25 ^{\circ}C$	I _D	-3.6 -2.8 ^{b, c}		
	T _A = 70 °C		-2.1 ^{b, c}	Α	
Pulsed drain current (t = 100 μs)		I _{DM}	-20	^	
Continuous source-drain diode current	T _C = 25 °C	1-	-4.5 ^a		
	T _A = 25 °C	I _s	-2.8 ^{b, c}		
Single pulse avalanche current L = 0.1 mH		I _{AS}	-15		
Single pulse avalanche energy	L = U.1 IIIII	E _{AS}	11.25	mJ	
Maximum power dissipation	T _C = 25 °C		27.8		
	T _C = 70 °C	1 ₆ [17.8	w	
	T _A = 25 °C	P _D	3.5 ^{b, c}	VV	
	T _A = 70 °C	Ī	2.2 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260	-0	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	29	36	°C/W		
Maximum junction-to-case (drain)	Steady state	R_{thJC}	3.6	4.6	C/VV		

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	•				•		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-100	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-63	-		
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	4.2	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	-1.1	-	-2.6	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current		V _{DS} = -100 V, V _{GS} = 0 V	-	-	-1		
	I _{DSS}	V _{DS} = -100 V, V _{GS} = 0 V, T _J = 70 °C	-	-	-10	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-15	-	-	Α	
Drain-source on-state resistance ^a	_	$V_{GS} = -10 \text{ V}, I_D = -3.8 \text{ A}$	-	0.110	0.132	Ω	
	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -3.2 \text{ A}$	-	0.155	0.186		
Forward transconductance a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -3.8 \text{ A}$	-	8	-	S	
Dynamic ^b	•				•		
Input capacitance	C _{iss}	V _{DS} = -50 V, V _{GS} = 0 V, f = 1 MHz	-	515	-		
Output capacitance	C _{oss}		-	162	-	pF	
Reverse transfer capacitance	C_{rss}		-	10	-		
Total gate charge	0	$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.8 \text{ A}$	-	10.9	16.5		
	Qg	33	-	5.65	8.5	nC	
Gate-source charge	Q _{gs}	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.8 \text{ A}$	-	1.7	-		
Gate-drain charge	Q_{gd}		-	2.5	-		
Gate resistance	Rq	f = 1 MHz	1.96	9.8	19.6	Ω	
Turn-on delay time	t _{d(on)}		-	10	20	-	
Rise time	t _r	$\begin{split} V_{DD} = -50 \text{ V, } R_L = 16.1 \Omega, I_D \cong -3.1 \text{ A,} \\ V_{GEN} = -10 \text{ V, } R_g = 1 \Omega \end{split}$	-	22	40		
Turn-off delay time	t _{d(off)}		-	20	40		
Fall time	t _f		-	20	40	1	
Turn-on delay time	t _{d(on)}		-	35	55	ns	
Rise time	t _r	$V_{DD} = -50 \text{ V}, R_L = 16.1 \Omega, I_D \cong -3.1 \text{ A}, \ V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	40	60	- - -	
Turn-off delay time	t _{d(off)}		-	22	40		
Fall time	t _f		-	1622	40		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	-16	_	
Pulse diode forward current	I _{SM}		-	-	-15	A	
Body diode voltage	V _{SD}	$I_S = -3.1 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.8	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	43	65	ns	
Body diode reverse recovery charge	Q _{rr}	1	-	80	120	nC	
Reverse recovery fall time	t _a	$I_F = -3.1 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	36	-		
Reverse recovery rise time	t _b	7		7	_	ns	

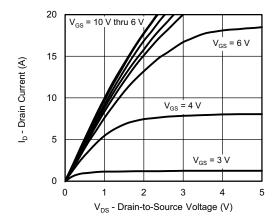
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

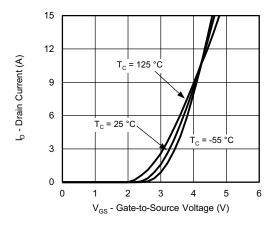
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



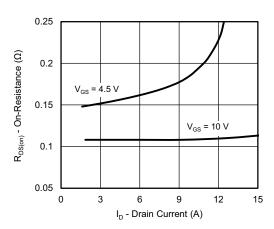
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



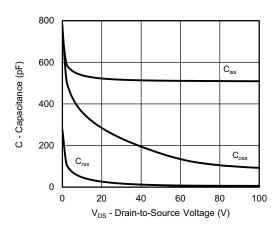
Output Characteristics



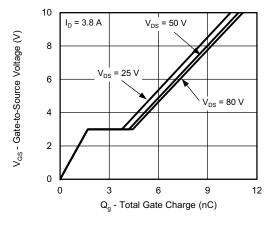
Transfer Characteristics



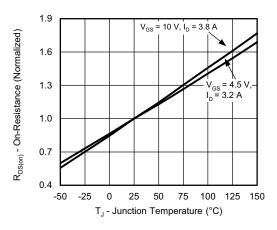
On-Resistance vs. Drain Current and Gate Voltage



Capacitance



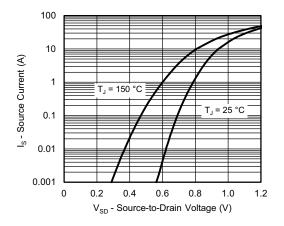
Gate Charge



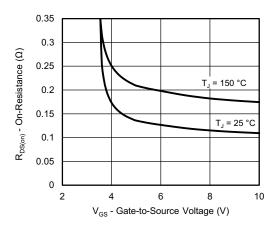
On-Resistance vs. Junction Temperature



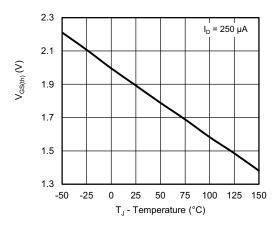
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



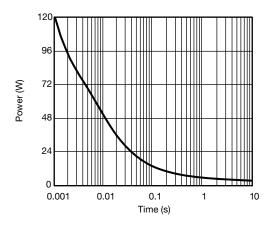
Source-Drain Diode Forward Voltage



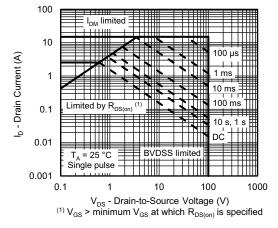
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



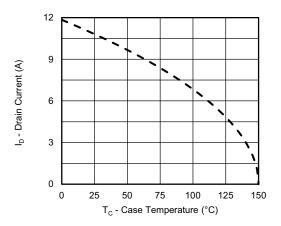
Single Pulse Power, Junction-to-Ambient



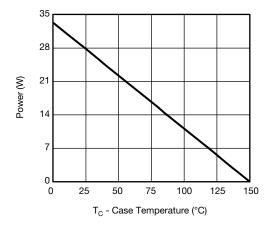
Safe Operating Area, Junction-to-Ambient



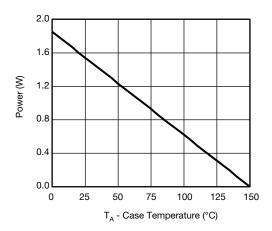
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating a







Power, Junction-to-Ambient

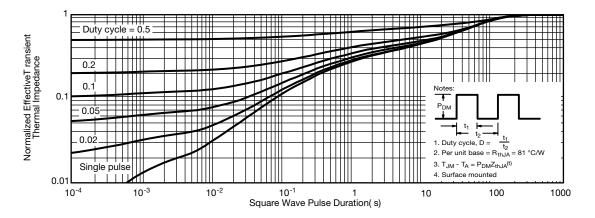
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

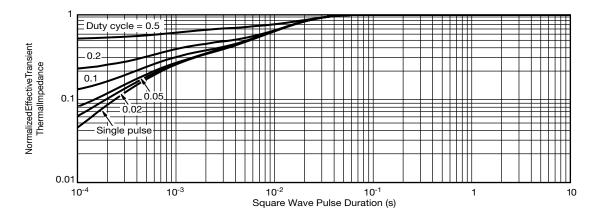
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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